

Search Notes

Application/Control No.

10/691,115

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under
Reexamination

ANDRYS ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	285	6/13/2007	NKV
1	296	1	1

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR